Logical Analysis of Multiclass Data

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Abstract

Logical Analysis of Data (LAD) is a two-class learning method which integrates principles of combinatorics, optimization, and the theory of Boolean functions. This paper proposes an algorithm based on mixed integer linear programming to extend the LAD methodology to solve multi-class classification problems, where One-vs-Rest (OvR) learning models are efficiently constructed to classify observations in predefined classes. The utility of the proposed approach is demonstrated through experiments on multi-class benchmark datasets.

1 Introduction

Data mining studies are concerned with extracting meaningful knowledge from large-scale datasets. While there are various data mining methodologies, considerable number of principle concepts appears in one form or another in many data mining applications. A typical data analysis pipeline comprises four phases: (1) data pre-processing (data transformation, imputation, feature selection/reduction), (2*a*) class discovery (clustering), or (2*b*) class comparison and discrimination (regression/classification), (3) evaluation (statistical tests/cross-validation), and (4) interpretation of the results.

With the advent of new technologies research in various fields has been shifted from hypothesis-driven to datadriven and classification problem has become ubiquitous in many real-world applications that require discrimination among predefined classes. Well-known classification algorithms such as support vector machines (Burges 1998; Schölkopf and Smola 2001), neural networks (Fausett 1994; Bishop 2007), decision trees (Bishop 2007; Duda, Hart, and Stork 2001), k-Nearest Neighbor (Aiolli 2004; Mitchell and Schaefer 2001), and Naive Bayes (Duda, Hart, and Stork 2001; Bishop 2007), etc., are designed to solve binary classification problems where a learning model is constructed to separate observations in two predefined classes. However, in many scenarios, it is desirable to have the ability to separate observations into more than two classes. Typical examples include identification of different subtypes

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of human cancers (Hanash and Creighton 2003), protein fold recognition (Ding and Dubchak 2001; Misselwitz et al. 2010), microscopy images (Boland et al. 1998), histogrambased image classification (Chapelle, Haffner, and Vapnik 1999), handwritten character recognition (LeCun et al. 1989; Lee and Seung 1997), part-of-speech tagging (Even-Zohar and Roth 2001), speech recognition (Jelinek 1998), text categorization (Apté, Damerau, and Weiss 1994; Dagan et al. 1997), etc. Since the problem is of practical importance, there have been several attempts to extend binary classification algorithms to multi-class problems in literature. Here are some of them: multiclass classification (Bevgelzimer, Langford, and Ravikumar 2007; Yang and Tsang 2012; Gehler and Nowozin 2009; Har-Peled, Roth, and Zimak 2002), discriminant analysis for multi-class classification (Liu et al. 2011; Li, Zhu, and Ogihara 2006), multiclass learning (Amit et al. 2007; Even-Zohar and Roth 2001), combining many two-class classifiers into a multiclass classifier (Platt, Cristianini, and Shawe-Taylor 2000; Wu, Lin, and Weng 2004; Tewari and Bartlett 2007; Tax and Duin 2002; Galar et al. 2011), multi-class classification with applications (Singh-Miller and Collins 2009), mixedinteger programming approach to multi-class data classification, (Üney and Türkay 2006; Guo and Ryoo 2012; Ryoo and Jang 2009), general multiclass classification methods reviews (Aly 2005), and multiclass classification by using support vector machines (Aiolli and Sperduti 2006).

The most common approaches to multi-class classification are the natural extension of binary classification problem known as One-vs-One (OvO) (Hastie and Tibshirani 1998) (also called All-vs-All) and One-vs-Rest (OvR) (also called One-vs-All). Given a K-class dataset, OvO scheme assumes that there exits a separator between any two classes and builds K(K-1)/2 classifiers, denoted by f_{ij} , to distinguish each pair of classes $C_i, C_j \in C$, where $C = \{C_1, \dots, C_K\}$. Note that $f_{ji} = -f_{ij}$. The class of a new/unseen observation o is then assigned by the use of the discriminant function

$$f(o) = \arg\max_{i} \sum_{j} f_{ij}(o).$$
(1.1)

A less expensive approach OvR assumes the existence of a single separator between a class C_i (for some *i*) and all other classes, and builds *K* different binary classifiers. Let

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 f_i be the *i*th classifier separating observations in class C_i (considered to be positive) and observations not in C_i (form the set of negative observations). In this case a new/unseen observation o is classified by

$$f(o) = \arg\max_{i} f_i(o). \tag{1.2}$$

Since both approaches are easy to adopt, diverse group of researchers invented them independently and the choice between the use of OvO and OvR in multi-class problems is largely computational.

In this paper we adopt the OvR approach and develop a systematic procedure which takes advantage of computerrelated developments and combinatorial optimization techniques, to extend a previously successful classification method, Logical Analysis of Data (LAD), to solve multiclass classification problems.

LAD is a pattern-based two-class learning method which integrates principles of combinatorics, optimization, and the theory of Boolean functions. The research area of LAD was introduced and developed by Peter L. Hammer (1986) whose vision expanded the LAD methodology from theory to successful data applications in numerous biomedical, industrial, and economics case studies, see, e.g., (Boros et al. 2000; Reddy 2009; Hammer, Kogan, and Lejeune 2011) and the references therein. The implementation of LAD algorithm was described in (Boros et al. 1997), and several further developments of the original algorithm were presented in (Alexe and Hammer 2006; Bonates, Hammer, and Kogan 2008; Hammer et al. 2004; Guo and Ryoo 2012; Ryoo and Jang 2009). An overview of standard LAD algorithm can be found in (Alexe et al. 2007; Bonates, Hammer, and Kogan 2008). Various recent applications of LAD are presented in (Dupuis, Gamache, and Pagé 2010; Esmaeili 2012; Kwok 2001; Lejeune and Margot 2011; Mortada, Yacout, and Lakis 2011). LAD method has been extended to survival analysis (Reddy 2009) and regression analysis (Bonates and Hammer 2007; Lemaire 2011) as well.

The key ingredient of two-class LAD method is the identification of patterns distinguishing between positive and negative observations in a dataset $\mathbb{ID} = \mathbb{ID}^+ \cup \mathbb{ID}^-$, where \mathbb{ID}^+ (set of positive observations) and \mathbb{ID}^- (set of negative observations) are two disjoint sets containing *n*-dimensional real vectors. LAD usually produces several hundreds (sometimes thousands) of patterns. Once all patterns are generated, a subset of patterns is selected by solving a set covering problem or by greedy-type heuristics to form an LAD classification model such that each positive (negative) observation is covered by at least one positive (negative) pattern (and ideally, is not covered by any negative (positive) pattern) in the model. The patterns selected into the LAD model are then used to define a discriminant function that allows the classification of new or unseen observations.

Extensions of LAD algorithm to multi-class problems are studied by Moreira (2000) and Mortada (2010). Moreira (2000) proposed two methods to break down a multiclass classification problem into two-class problems using an OvO approach. The first method uses the typical OvO type approach which does not require the alteration of the structure of the standard LAD algorithm as described in (Boros et al. 2000). The second OvO-type method modifies the architecture of the pattern generation and theory formation steps in standard LAD method, where an LAD pattern P_{ij} is generated for each pair of classes $C_i, C_j \in C, i \neq j$. After a pattern P_{ij} is generated, its behavior on classes C_k for all $k \neq i, j$ is examined. These classes can acquire three different status, called "positive", "negative", or "neutral", with regard to pattern P_{ij} . These status are determined by the use of the coverage rate of pattern P_{ij} on class $C_k, k \neq i,$ j, that is, the proportion of observations from C_k covered by pattern P_{ij} . Given a dataset with K different classes, the proposed methodology of Moreira (2000) generates a multiclass LAD model \mathcal{M} and a decomposition matrix D of size $|\mathcal{M}| \times K$ with entries

$$d_{pk} = \begin{cases} \omega_k^{(P_{ij})} & \text{if } \omega_k^{(P_{ij})} \ge \omega^+ \\ 0 & \text{if } \omega^- < \omega_k^{(P_{ij})} < \omega^+ \\ -1 & \text{if } \omega_k^{(P_{ij})} \le \omega^- \end{cases}$$

where $1 \leq p \leq |\mathcal{M}|$, $1 \leq k \leq K$ and $0 \leq \omega_k^{(P_{ij})} \leq 1$ is the coverage rate of pattern P_{ij} on class C_k , and ω^+ , ω^- are user-defined parameters. The value of entry d_{pk} determines the status of class C_k with regard to pattern P_{ij} . The proposed algorithm also generates a matrix R of size $K \times K$, where each entry stores the differentiability rate of class C_i from class C_j , that is, the ratio of observations in C_i covered by patterns in \mathcal{M} which do not cover (or only cover a small proportion of) observations in C_j . The authors of (Moreira 2000) observed that their second approach produces less accurate classification models than those obtained by the first approach, however, decision rules generated by second approach are more intuitive as they relate several classes at the same time.

The paper by Mortada (2010) proposed a multi-class LAD method algorithm which integrates ideas from the second approach presented by Moreira (2000) which is based on OvO approach and an implementation of LAD based on mixed integer linear programming (MILP) presented by Ryoo and Jang (2009). The methodology of Mortada (2010) was applied to three multi-class benchmark datasets. The authors of this paper observed that the MILP based LAD approach of Ryoo and Jang (2009) combined with the second approach of Moreira (2000) provides classification models with higher accuracy than those models obtained by Moreira (2000) approach applied to standard LAD algorithm.

In this paper we propose an algorithmic approach based on mixed integer linear programming (MILP) to efficiently build an OvR-type LAD classifier to identify patterns in a multi-class dataset. The organization of the paper is as follows. Section 2 describes the basic principles of the standard LAD algorithm. In Section 3 we present our MILP based algorithmic approach to extend LAD to multi-class data analysis, where we obtain OvR-type multi-class LAD classifier. In Section 4 we present experiments on five multiclass benchmark datasets to demonstrate the utility of our proposed methodology.

2 Preliminaries: Logical Analysis of Data

Logical Analysis of Data (LAD) is a two-class learning algorithm based on combinatorics, optimization, and the theory of Boolean functions. The input dataset, ID, consists of two disjoint classes ID^+ (set of positive observations) and ID^- (set of negative observations), that is, $ID = ID^+ \cup ID^-$ and $ID^+ \cap ID^- = \emptyset$. The main task of LAD algorithm is to identify patterns separating the positive and negative observations based on features measured (Boros et al. 2000). Below we briefly outline the basic components of the LAD algorithm. A more detailed overview can be found in (Alexe and Hammer 2006; Hammer and Bonates 2006).

2.1 Discretization/Binarization and Support Set Selection

This step is the transformation of numeric features (attributes/variables) into several binary features without losing predictive power. The procedure consists of finding cutpoints for each numeric feature. The set of cut-points can be interpreted as a sequence of threshold values collectively used to build a global classification model over all features (Boros et al. 2000). Discretization is a very useful step in data mining, especially for the analysis of medical data (which is very noisy and includes measurement errors) – it reduces noise and produces robust results. The problem of discretization is well studied and many powerful methods are presented in literature, see, e.g., the survey papers (Kotsiantis and Kanellopoulus 2006; Liu et al. 2004)).

Discretization step may produce several binary features some of which may be redundant. Support set is defined as the smallest (irredundant) subset of binary variables which can distinguish every pair of positive and negative observations in the dataset. Support sets can be identified by solving a minimum set covering problem (Boros et al. 2000).

2.2 Pattern Generation

Patterns are the key ingredients of LAD algorithm. This step uses the features in combination to produce rules (combinatorial patterns) that can define homogenous subgroups of interest within the data. The simultaneous use of two or more features allows the identification of more complex rules that can be used for the precise classification of an observation.

Given a binary (or binarized) dataset $\mathbb{D} = \mathbb{D}^+ \cup \mathbb{D}^-$, where $\mathbb{D}^+ \cap \mathbb{D}^- = \emptyset$, a *pattern* P is simply defined as a subcube of $\{0,1\}^n$, where n is the number of features in the dataset. A pattern can be also described as a Boolean term, that is, a conjunction of literals (binary variables or its negation) which does not contain both a variable and its negation:

$$P = \bigwedge_{j \in N_P} x_j$$

where $N_P \subseteq \{1, \dots, n\}$ and x_j is a binary variable. The number of literals (associated with features) involved in the definition of a pattern is called the *degree* of the pattern.

Patterns define homogeneous subgroups of observations with distinctive characteristics. An observation $o \in ID$ satisfying the conditions of a pattern P, i.e., P(o) = 1, is

said to be *covered* by that pattern. A pure positive (negative) pattern is defined as a combination of features which covers a proportion of positive (negative) observations, but none of the negative (positive) ones: P(o) = 1 for at least one $o \in \mathbb{D}^+$ (or, $o \in \mathbb{D}^-$), and P(o) = 0 for every $o \in \mathbb{D}^-$ (or, $o \in \mathbb{D}^+$). *Coverage* of a positive (negative) pattern P, denoted by Cov(P), is the set of observations $o \in \mathbb{D}^+(or, o \in \mathbb{D}^-)$ for which P(o) = 1. A pattern P is called a *strong pattern* if there is no pattern P' such that $Cov(P) \subset Cov(P')$. Pattern P is called a *prime pattern* if the deletion of any literal from P results in a term that is no longer a pattern.

The most straightforward approach to pattern generation is based on the use of combinatorial enumeration techniques, for example, a bottom-up/top-down approach as described by Boros et al. (2000). The bottom-up approach follows a lexicographic order in generating the patterns in order to reduce the amount of computations necessary. The approach starts with terms of degree one that cover some positive observations. If such a term does not cover any negative observation, it is a positive pattern. Otherwise, literals are added to the term one by one until generating a pattern of prefixed degree. The top-down pattern generation approach starts by considering all uncovered observations as patterns of degree n and for each of those patterns, literals are removed one by one, until a prime pattern is reached. The enumeration type pattern generation approach is a costly process. Given a two-class binary dataset with n features, the total number of candidate patterns to be searched is $\sum_{i=1}^{n} 2^{i} \binom{n}{i}$ and the number of degree d patterns can be $2^{d} \binom{n}{d}$.

Since patterns play a central role in LAD methodology, various types of patterns (e.g., prime, spanned, maximum) have been studied and several pattern generation algorithms have been developed for their enumeration (Alexe et al. 2007; Bonates, Hammer, and Kogan 2008; Hammer et al. 2004; Guo and Ryoo 2012; Ryoo and Jang 2009). Our OvR-type multi-class LAD algorithm is motivated by the MILP approach of Ryoo and Jang (2009) that generates strong LAD patterns in a two-class dataset. This approach is out-lined below:

Consider a two-class dataset \mathbb{D} consisting of m binary observations and n features. Let $I^+ = \{i : o_i \in \mathbb{D}^+\}$ and $I^- = \{i : o_i \in \mathbb{D}^-\}$, where $\mathbb{D} = \mathbb{D}^+ \cup \mathbb{D}^-$ and $\mathbb{D}^+ \cap$ $\mathbb{D}^- = \emptyset$. For each observation $o_i \in \mathbb{D}$, let o_{ij} denote the binary value of the *j*-th feature in that observation. Let a_j , $j = 1, \dots, n$, denote the features in \mathbb{D} and introduce n new features $a_{n+j} = 1 - a_j$, $j = 1, \dots, n$ (negation of a_j). Ryoo and Jang (2009) formulated the following MILP to generate strong patterns:

Minimize
$$z = c d + \sum_{i \in I^+} w_i$$

subject to
 $\sum_{\substack{j=1\\2n}}^{2n} o_{ij} y_j + n w_i \ge d, \quad i \in I^+$
 $\sum_{\substack{j=1\\y_j + y_{n+j} \le 1, \quad j = 1, \cdots, n}^{2n} i \in I^-$ (2.3)
 $\sum_{\substack{j=1\\2n}}^{2n} y_j = d; \quad 1 \le d \le n$
 $w_i, y_j \in \{0, 1\}, \ i = 1, \cdots, m; \ j = 1, \cdots, 2n$

where $c \in \mathbb{R}$ is a constant and variables y_j and y_{n+j} are associated with features a_j and a_{n+j} , $j = 1, \dots, n$, respectively. Binary variables w_i 's are associated with the coverage of a positive pattern P and are defined by

$$w_i = \begin{cases} 1 & \text{if } P(o_i) = 0, \ i \in I^+ \\ 0 & \text{if } P(o_i) = 1, \ i \in I^+ \end{cases}$$

Ryoo and Jang (2009) proved that when c > 0, an optimal solution (**w**, **y**, d) of problem (2.3) is a positive strong prime pattern of the form:

$$P = \bigwedge_{\{j : y_j = 1, j = 1, \cdots, n\}} a_j \bigwedge_{\{j : y_{n+j} = 1, j = 1, \cdots, n\}} \bar{a}_j$$

Note that if we change the roles of index sets I^+ and I^- in problem (2.3), an optimal solution of the problem provides us with a pure negative strong prime pattern when c > 0.

2.3 LAD Model

An LAD model is a collection of positive and negative patterns which provides the same separation of the positive and negative observations as the entire collection of patterns, called *pandect* and denoted by $\mathcal{P} = \mathcal{P}^+ \cup \mathcal{P}^-$, where \mathcal{P}^+ and \mathcal{P}^- are disjoint sets of all positive and negative patterns generated in pattern generation step, respectively. In many cases, when constructing an LAD model, every observation in the training dataset is required to be covered at least k times $(k \in \mathbb{Z}^+)$ by the patterns in the model, $\mathcal{M} = \mathcal{M}^+ \cup \mathcal{M}^-$, where $\mathcal{M}^+ \subseteq \mathcal{P}^+$ and $\mathcal{M}^- \subseteq \mathcal{P}^-$. Such an LAD model can be obtained from the pandect \mathcal{P} by solving a set covering problem. However, in general, the size of the pandect is very large. In this case the standard LAD algorithm (where patterns are generated by, for example, top-down/bottom-up approach) uses greedy heuristics to solve the set-covering problem to generate an LAD model.

In case of MILP approaches to generate LAD patterns, Ryoo and Jang (2009) presented the following *pattern generation* algorithm based on their MILP approach to produce an LAD model (a set of positive and negative patterns):

Algorithm 1 generates the minimum number of patterns required to cover the training data set. Note that after a pattern is generated, observations covered by that pattern is deleted from the training data to prevent the algorithm from

Algorithm 1: Pattern Generation
Data: Training data, Support Features, MILP model
(2.3) for pattern generation
Result : Set of $+$ and $-$ patterns (\mathcal{M}^+ and \mathcal{M}^- , resp.)
1 for $* \in \{+, -\}$ do
2 set $\mathcal{M}^* = \emptyset$;
3 while $I^* \neq \emptyset$ do
4 formulate and solve an instance of the MILP
problem (2.3);
5 form a pattern P from the solution obtained;
$6 \mathcal{M}^* \leftarrow \mathcal{M}^* \cup \{P\};$
7 $I^* \leftarrow I^* \setminus \{i \in I^* : o_i \text{ is covered by } P\};$
8 return \mathcal{M}^{+} ;

finding the same pattern found in the previous solutions of problem (2.3). The resulting set of positive and negative patterns form an LAD model \mathcal{M} .

2.4 Classification and Accuracy

Given an LAD model $\mathcal{M} = \mathcal{M}^+ \cup \mathcal{M}^-$, the classification of a new/unseen observation $o \notin \mathbb{D}$ is determined by the sign of a discriminant function $\Delta : \{0, 1\}^n \to \mathbb{R}$ associated with the model \mathcal{M} , where $\Delta(o)$ is defined as the difference between the proportion of positive patterns and negative patterns covering o, that is,

$$\Delta(o) = \sum_{P_k^+ \in \mathcal{M}^+} \omega_k^+ P_k^+(o) - \sum_{P_k^- \in \mathcal{M}^-} \omega_k^- P_k^-(o),$$

where $\omega_k^+ \ge 0$ and $\omega_k^- \ge 0$ are the weights assigned to positive patterns $P_k^+ \in \mathcal{M}^+$ and negative patterns $P_k^- \in \mathcal{M}^-$, respectively. The weights ω_k^+ and ω_k^- can be calculated in several ways. One possibility is to use the proportion of positive (negative) observations covered by a positive pattern $P_k^+ \in \mathcal{M}^+$ (a negative pattern $P_k^- \in \mathcal{M}^-$) to the total number of positive (negative) observations (called the prevalence of a pattern):

$$\omega_{k}^{+} = \frac{1}{\left|\mathbb{D}^{+}\right|} \sum_{i \in I^{+}} P_{k}^{+}(o_{i}) \quad \text{and} \quad \omega_{k}^{-} = \frac{1}{\left|\mathbb{D}^{-}\right|} \sum_{i \in I^{-}} P_{k}^{-}(o_{i})$$

where $I^+ = \{i : o_i \in \mathbb{D}^+\}$, and $I^- = \{i : o_i \in \mathbb{D}^-\}$.

The accuracy of the model is estimated by classical crossvalidation procedure (Dietterich 1998; Efron and Tibshirani 1986; Hastie et al. 2005; Kohavi 1995). If an external dataset (test/validation set) is available, the performance of model \mathcal{M} is evaluated on that set.

3 Multi-class LAD Algorithm

In this section we present an OvR-type extension of LAD algorithm to multi-class classification problems. As in conventional LAD algorithm our multi-class LAD approach has four steps: (i) binarization and support set selection, (ii) pattern generation, (iii) theory formation, and (iv) classification and accuracy. These steps are discussed below.

3.1 Binarization and Support Set Selection

Binarization of a multi-class numeric data is similar to that of two-class data discussed in Section 2.1. Binarization step associates several cut-points, α_{v_k} , and the following indicator variables to a numeric feature v to transform it into a set of binary features:

$$x_{v_k} = \begin{cases} 1 & \text{if } v \ge \alpha_{v_k} \\ 0 & \text{if } v < \alpha_{v_k} \end{cases}$$

Transforming the data from discrete levels to indicator variables results in a multi-class binary dataset. For each variable, virtually any numerical value can be considered as a cut-point. However, the cut-points are chosen in a way which allows to distinguish between observations in different classes, see e.g., (Kotsiantis and Kanellopoulus 2006). The multi-class discretization problem is extensively studied and there are different approaches to accomplish this task (Friedman et al. 2000).

In what follows we develop our multi-class LAD method under the assumption that we are given a binary (or binarized) multi-class dataset.

3.2 Pattern Generation: MILP Based Approach

Let $\mathbb{D} = \mathbb{D}_1 \cup \cdots \cup \mathbb{D}_K$ be a K-class binary dataset with *n* features and *m* observations. Let $\mathcal{C} = \{\mathcal{C}_1, \cdots, \mathcal{C}_K\}$ denote the corresponding family of classes in \mathbb{D} , that is, any observation in \mathbb{D}_k has class \mathcal{C}_k ($k = 1, \cdots, K$).

In order to formulate an MILP to generate a pattern P_{C_p} covering some of the observations in class C_p and none of the observations in C_k , $k \neq p$, we proceed as follows:

(1) Associate a vector y = (y₁, ..., y_{2n}) ∈ {0,1}²ⁿ to pattern P_{C_p}, where the components y₁, ..., y_{2n} of vector y are relative to the features such that if we have y_j = 1 for some j = 1, ..., n, then the literal x_j (associated with the j-th feature in ID) is included in pattern P_{C_p} and if y_{n+j} = 1, then the literal x_j (complement of x_j) is included in pattern P_{C_p}. Since a pattern cannot include both x_j and x_j, we impose the condition

$$y_j + y_{n+j} \le 1, \ j = 1, \cdots, n.$$
 (3.4)

(2) Define a binary vector w = (w₁, w₂, ..., w_m) that is associated with the coverage of the pattern P_{C_p} and will be used to score penalization as follows: For 1 ≤ i ≤ m

$$w_i = \begin{cases} 1 & \text{if } o_i \in \mathcal{C}_p \text{ is not covered by pattern } P_{\mathcal{C}_p} \\ 0 & \text{otherwise.} \end{cases}$$

(3) Consider the augmented matrix B = [ID|ID], where ID is the binary data obtained from ID by replacing 0 entries by 1 and 1 entries by 0. Define the vector v = By. In order to produce a pure pattern P_{Cp} with degree d we prescribe the following constraints:

$$v_i + nw_i \ge d, \quad i \in I_p , \tag{3.5}$$

$$v_i \leq d-1, \quad i \in I_k \ , \ k=1,\cdots,K \ \text{ and } \ k \neq p \ (3.6)$$

and

$$\sum_{j=1}^{2n} y_j = d , \qquad (3.7)$$

where $1 \leq d \leq n$, $I_p = \{i : o_i \text{ is in class } C_p\}$ and $I_k = \{i : o_i \text{ is in class } C_k\}$ for all $k \neq p$.

The conditions in (3.4)-(3.7) can be used to write an MILP whose optimal solution produces a pure pattern P_{C_p} associated with class C_p for some $1 \le p \le K$ as shown below:

$$\begin{array}{ll} \text{Minimize } z = d + \sum_{i \in I_p} w_i \\ \text{subject to} \\ v_i + nw_i \ge d, \quad i \in I_p \\ v_i \le d - 1, \quad i \in I_k, \ k = 1, \cdots, K, \ k \ne p \\ y_j + y_{n+j} \le 1, \quad j = 1, 2, \cdots, n \\ \sum_{j=1}^{2n} y_j = d; \qquad 1 \le d \le n \\ w_i, y_j \in \{0, 1\}, \ i = 1, \cdots, m; \ j = 1, \cdots, 2n \end{array}$$

$$(3.8)$$

Notice that problem (3.8) is a modified version of the MILP problem (2.3) of Ryoo and Jang (2009) that is designed to generate patterns in a two-class dataset. An optimal solution of problem (3.8) can be used to form a pure strong prime pattern P_{C_p} associated with class C_p , $1 \le p \le K$. The objective function of (3.8) ensures that the coverage of pattern P_{C_p} is maximized and the degree of P_{C_p} (i.e., the number of literals used in P_{C_p}) is as small as possible. These assertions are provided in the following two theorems:

Theorem 3.1. Let $(\mathbf{v}^*, \mathbf{y}^*, \mathbf{w}^*, d^*)$ be a feasible solution of problem (3.8). Then

$$P_{\mathcal{C}_p} = \bigwedge_{\{j:y_j^*=1, j=1, \cdots, n\}} x_j \bigwedge_{\{j:y_{n+j}^*=1, j=1, \cdots, n\}} \bar{x}_j \quad (3.9)$$

forms a pattern of degree d associated with class C_p .

Proof. Let $(\mathbf{v}^*, \mathbf{y}^*, \mathbf{w}^*, d^*)$, where $\mathbf{v}^* = B\mathbf{y}^*$, be a feasible solution of problem (3.8). First note that the constraint $y_j + y_{n+j} \le 1$, $j = 1, \cdots, n$ ensures that the Boolean term $P_{\mathcal{C}_p}$ shown in (3.9) does not contain both x_j and \bar{x}_j associated with the *j*th feature in dataset \mathbb{ID} and the condition $\sum_{j=1}^{2n} y_j = d$ guarantees that the term $P_{\mathcal{C}_p}$ is of degree d. The constraint $v_i + nw_i \ge d$, $i \in I_p$ ensures that $P_{\mathcal{C}_p}$ covers at least one observation o_i in class \mathcal{C}_p , that is, $P_{\mathcal{C}_p}(o_i) = 1, i \in I_p$. If an observation $o_i, i \in I_p$, is covered by $P_{\mathcal{C}_p}$, then $d y_j$'s are set to 1 and hence, we have $v_i = d, i \in I_p$, where v_i is the *i*th component of vector $\mathbf{v} = B\mathbf{y}$. However, if an observation is not covered by $P_{\mathcal{C}_p}$, then $v_i < d, i \in I_p$, and the term " nw_i " is added to the left hand side to compensate it. Similarly, the condition $v_i \leq d-1, \quad i \in I_k, \ k=1, \cdots, K \text{ and } k \neq p \text{ guarantees}$ that the term $P_{\mathcal{C}_p}$ does not cover any observation $o_i, i \notin I_p$. Thus, the solution $(\mathbf{v}^*, \mathbf{y}^*, \mathbf{w}^*, d^*)$ can be used to form a pure pattern $P_{\mathcal{C}_p}$ of degree d that is associated with class \mathcal{C}_p .

Theorem 3.2. Let $(\mathbf{v}^*, \mathbf{y}^*, \mathbf{w}^*, d^*)$ be an optimal solution of problem (3.8). Then the pattern (3.9) is a strong prime pattern of degree d associated with class C_p .

Proof. Let $(\mathbf{v}^*, \mathbf{y}^*, \mathbf{w}^*, d^*)$ be an optimal solution of problem (3.8), hence, as discussed in the proof of Theorem 3.1, it can be used to construct a pure pattern $P_{\mathcal{C}_n}$ of degree d

that is associated with class C_p . Note that the objective function of problem (3.8) minimizes d and the sum $\sum_{i \in I_p} w_i$. When $\sum_{i \in I_p} w_i$ is minimized the optimal solution to the model ultimately tries to minimize the number of observations in I_p that are not covered by the constructed pattern. Similarly, at an optimal solution $(\mathbf{v}^*, \mathbf{y}^*, \mathbf{w}^*, d^*)$, the term d(corresponding to the degree of a pattern) is minimum. As a result, an optimal solution to problem (3.8) can be used to form a pattern with maximum coverage and minimum degree. The resulting pattern is a strong prime pattern.

Note that problem (3.8) produces a strong prime pattern P_{C_p} that covers some of the observations in class C_p , but none of the observations in C_k , $k \neq p$. Recall that an LAD model is a set of patterns where each observation is covered by at least one pattern. In order to produce set of patterns associated with class C_k , $k = 1, \dots, K$, we shall use an algorithmic approach as described below.

3.3 Theory Formation: One-versus-Rest (OvR) Type Multi-class LAD Algorithm

In this section we present an algorithm that produces an OvR-type multi-class LAD model based on the multi-class MILP approach given in Section 3.2. Note that in case of two-class MILP approach, Algorithm 1 of Ryoo and Jang (2009) (shown in Section 2.3) produces a set of patterns associated with a positive (negative) class that loops as many times as necessary until all observations in positive (negative) class are covered by at least one pattern. The setup proposed by Ryoo and Jang (2009) is inconvenient because a single pattern is sufficient to cover every observation in positive (negative) class which results in a classifier with small number of patterns and hence, poor differentiating power between the two classes of a dataset. In such cases the prediction of a new or unseen observation would depend on a single or a few patterns. Note also that once a positive (negative) pattern P is found as an optimal solution of problem (2.3), in order to produce a new positive (negative) pattern P', i.e., another optimal solution of problem (2.3), Algorithm 1 removes the observations covered by pattern P while execution. This is counterproductive because every time the algorithm uses less information (smaller training set) to compute new patterns. Mortada (2010) has adopted a similar approach to develop an OvO-type multi-class LAD algorithm, where observations covered by a pattern are removed from the training dataset while execution of the proposed algorithm (see page 87 of (Mortada 2010)). The difference between Ryoo-Jang's algorithm (2009) and Mortada's algorithm (2010) is that in Mortada's algorithm the looping stops when each observation is covered by l patterns.

In order to avoid the removal of observations from the training dataset when generating new patterns that forms a multi-class LAD model, we modify constraint (3.5) as follows:

Define κ as an *m*-vector that keeps track of the number of patterns covering an observation $o_i \in \mathbb{ID}$ for all $i = 1, \dots, m$. Initially, for each class $C_k, 1 \leq k \leq K$ we set $\kappa = 0$. This vector shall be updated as new solutions of the

MILP problem (3.8) are found. With the help of new vector κ , condition (3.5) can be replaced by

$$w_i + n\left(w_i + \kappa_i\right) \ge d, \quad i \in I_p . \tag{3.10}$$

where $\kappa_i \geq 0, i = 1, \cdots, m$.

Theorem 3.3. Let $(\mathbf{v}', \mathbf{y}', \mathbf{w}', d')$ be an optimal solution of problem (3.8) where the constraint

$$v_i + nw_i \ge d, \quad i \in I_p$$

is replaced by constraint (3.10). Then

$$P_{\mathcal{C}_p} = \bigwedge_{\{j:y_j'=1,j=1,\cdots,n\}} x_j \bigwedge_{\{j:y_{n+j}'=1,j=1,\cdots,n\}} \bar{x}_j$$

is a degree d strong prime pattern associated with class C_p .

Proof. The proof of the assertion follows immediately from the proof of Theorem 3.1 and Theorem 3.2.

In Algorithm 2 we present our *multi-class LAD algorithm* that produces a multi-class LAD model (a set of patterns associated with class C_p for all $p = 1, \dots, K$). The algorithm is designed to loop as many times as needed until every observation in the training dataset is covered by at least one pattern. To ensure that the MILP problem (3.8) produces a different optimal solution (to be used to form a pattern P_{C_p} associated with class C_p , $p = 1, \dots, K$) at each iteration, we add systematically a new constraint requiring that an uncovered observation to be covered at the next iteration. Since the degree d of a pattern is also a decision variable in our MILP problem (3.8), in the worst case it would be possible to generate a pattern of degree n to cover a particular observation. Hence, the algorithm ensures that every observation in the dataset is covered by at least one pattern.

Algorithm 2 produces a multi-class LAD model $\mathcal{M} = \mathcal{M}_1 \cup \cdots \cup \mathcal{M}_K$ where $\mathcal{M}_k, k = 1, \cdots, K$, is the set of strong prime patterns associated with class $\mathcal{C}_k, k = 1, \cdots, K$, and $\mathcal{M}_i \cap \mathcal{M}_j = \emptyset$ for any $i \neq j$.

Note that in Algorithm 2 we do not require the removal of observations from the training dataset at any iteration. The first iteration of Algorithm 2 generates a strong prime pattern by the use of an optimal solution of the original MILP problem (3.8) and it does not contain any added constraints. However, *NewConstraint* is added to the MILP model each time a new pattern is generated to prevent the algorithm from finding the same pattern found at the previous iterations. This is achieved by introducing κ_i that keeps track of the number of patterns covering observations $o_i \in ID$ and TotCov that counts the number of observations covered so far.

Another important characteristics of our multi-class LAD algorithm is that it can detect the inconsistency among the observations in the given dataset ID. For example, if we have two observation $o_i = o_j$ where $i \in I_p$ and $j \in I_q$ $(p \neq q)$, then the MILP problem (3.8) is infeasible. Also, Algorithm 2 can be implemented by taking an advantage of parallel programming where a different computer kernel is used to compute a set of patterns associated with a specific class C_p . Algorithm 2: Multi-class LAD Algorithm

Input: *p*: index of current class 1 Global data: ID: binary dataset, b: class vector **Result**: MyPats[p] : patterns for class C_p 2 $B = [\mathbb{D} | \overline{\mathbb{D}}];$ 3 $\mathbf{v} = \hat{B} \mathbf{y}$; (* y unknown variable *) 4 MyPats $[p] = \{\};$ 5 $\kappa = 0;$ $NewConstraint = \{\};$ 6 TotCov = 0;7 while $TotCov < |I_p|$ do 8 $\mathcal{R} = \{ \text{Eq.}(3.4), \cdots, \text{Eq.}(3.7) \} \cup NewConstraint; \}$ 9 $pat = Minimize \left| d + \sum_{i \in I_p} w_i : \mathcal{R} \text{ and } \mathbf{v}, \mathbf{y}, \mathbf{w}, d \in \mathbb{Z}
ight|$ 10 \mathbf{y}^* part of *pat* corresponding to variables \mathbf{y} ; for i = 1 to m do 11 if $v_i = d$ then 12 $| \quad \kappa_i = \kappa_i + 1;$ 13 TotCov = 0;14 15 for i = 1 to m do if $(i \in I_p) \land (\kappa_i \neq 0)$ then 16 TotCov = TotCov + 1;17 NotFound = True;18 for i = 1 to m do 19 if 20 $(i \in I_p) \land (\kappa_i = 0) \land (v_i < d) \land (NotFound)$ then $NewConstraint = \{v_i = d\}; (* d \text{ and } Y)$ 21 as unknown variables *) NotFound = False;22 $MyPats[p] = MyPats[p] \cup \{\mathbf{y}^*\};$ 23 24 return MyPats[p];

3.4 Classification and Accuracy

Given a K-class dataset $\mathbb{D} = \mathbb{D}_1 \cup \cdots \cup \mathbb{D}_K$ and a corresponding multi-class LAD model $\mathcal{M} = \mathcal{M}_1 \cup \cdots \cup \mathcal{M}_K$, $(\mathcal{M}_i \cap \mathcal{M}_j = \emptyset, i \neq j)$, the classification of a new (or unseen) observation $o \notin \mathbb{D}$ is determined by the value of the discriminant function

$$\Delta(o) = \arg\max_{k} \Delta_k(o) \tag{3.11}$$

where $\Delta_k(o) = \sum_{P_{\mathcal{C}_k} \in \mathcal{M}_k} \omega_k P_{\mathcal{C}_k}(o), \quad k = 1, \cdots, K$ and $\omega_k \geq 0$ are the weights assigned to patterns $P_{\mathcal{C}_k} \in \mathcal{M}_k$. The weights $\omega_k, k = 1, \cdots, K$) can be calculated in several ways. One possibility is to use the prevalence of patterns that is defined by $\omega_k = \frac{1}{|\mathbb{ID}_k|} \sum_{i \in I_{\mathcal{C}_k}} P_{\mathcal{C}_k}(o_i)$, where $\mathbb{ID}_k \subset \mathbb{ID}$ is

the set of observations in class C_k and $I_{C_k} = \{i : o_i \in \mathbb{D}_k\}$ for some $1 \le k \le K$. If $\Delta(o) = \Delta_p(o) = \Delta_q(o)$ for some $p \ne q$, then the observation o is unclassified. Similar to the two-class classification problem the accuracy of a multi-class model \mathcal{M} is estimated by classical cross-validation procedure (Dietterich 1998; Efron and Tib-shirani 1986; Hastie et al. 2005; Kohavi 1995). If an external dataset (test/validation set) is available, the performance of the model is evaluated on that set.

4 Experiments

In this section we present experimental results to show how Algorithm 2 described in Section 3.3 can be used to solve multi-class classification problems. Regarding to the stopping criterion, Algorithm 1 ends (by construction) once all the patterns for each class have been computed. In the worse case, an ad hoc pattern can be built by the algorithm to cover a single observation. In our experiments we depend on the Mathematica procedure **Minimize** to generate our patterns by solving the corresponding MILP. It the discretization step has been done properly, each one of the MILP computed in Algorithm 1 is feasible. It could be advisible to set a time limit when invoke Algorithm 2, however in our experiments this was not necessary.

4.1 An overview of experiments

In order to test our proposed multi-class LAD methodology we conduct experiments on five multi-class datasets from UCI Machine Learning Repository¹. We implemented Algorithm 2 implemented in Wolfram Mathematica 8 on an Intel CORE i7 laptop with 12 GB Memory running Windows 7 computer. The set of patterns associated with a specific class C_p ($p = 1, \dots, K$) is generated by the use of Mathematica parallel programming command:

ParallelMap[*Multi-class LAD Algorithm*, Range[K]]

where K = |C|. **ParallelMap** applies Algorithm 2 in parallel to each class C_p , $p = 1, \dots, K$.

Parallel programming speeds up the pattern seeking process because we can invoke Algorithm 2 simultaneously but for different class. The steps of our experiments are outlined below:

- (i) Divide the K-class binary (or binarized) dataset $\mathbb{D} = \mathbb{D}_1 \cup \cdots \cup \mathbb{D}_K$ into two disjoint datasets \mathbb{D}_{TR} (training set) and \mathbb{D}_{TS} (test set) such that $\mathbb{D} = \mathbb{D}_{\mathrm{TR}} \cup \mathbb{D}_{\mathrm{TS}}$ and $\mathbb{D}_{\mathrm{TR}} \cap \mathbb{D}_{\mathrm{TS}} = \emptyset$. The partitioning of \mathbb{D} into subsets \mathbb{D}_{TR} and \mathbb{D}_{TS} is done randomly by ensuring that the number of observations with class \mathcal{C}_k in those subsets are proportional to the number of observations with class \mathcal{C}_k in the original dataset \mathbb{D} for all $k = 1, \cdots, K$.
- (ii) Run the multi-class LAD algorithm on the training set \mathbb{D}_{TR} to obtain a multi-class LAD model $\mathcal{M} = \mathcal{M}_1 \cup \cdots \cup \mathcal{M}_K$, $(\mathcal{M}_i \cap \mathcal{M}_j = \emptyset, i \neq j)$, where every observation in \mathbb{D}_{TR} is covered by at least one pattern in \mathcal{M} .
- (*iii*) For each observation $o \in \mathbb{D}_{TS}$ find the value of

$$\Delta_k(o) = \sum_{P_{\mathcal{C}_k} \in \mathcal{M}_k} \omega_k P_{\mathcal{C}_k}(o), \qquad k = 1, \cdots, K$$

¹http://archive.ics.uci.edu/ml/

Dataset	No. of Observations / Class	No. of Features
Iris	50 / 1, 50 / 2, 50 / 3	4
CNAE-9	70 / 1, 57 / 2, 59 / 3, 62 / 4, 58 / 5, 60 / 6, 56 / 7, 54 / 8, 64 / 9	857
Synthetic control	100 / 1, 100 / 2,100 / 3, 100 / 4, 100 / 5, 100 / 6	60
Glass ID	69 / 1, 76 / 2, 17 / 3, 13 / 4, 9 / 5, 29 / 6	10
Wine	59 / 1, 71 / 2, 48 / 3	12

Table 1: Five multi-class datasets from UCI repository

Dataset	Accuracy	Standard Deviation	Completion Time (seconds)
Iris	94%	2.2	16.7
CNAE-9	80.40%	1.75	102,589
Synthetic control	90.33%	2.4	19436
Glass ID	79.54%	5.35	1578
Wine	91.33%	3.54	236.5

Table 2: Average accuracy and completion time

- (*iv*) Use the discriminant function $\Delta(o)$ in equation (3.11) to assign each observation $o \in \mathbb{ID}_{TS}$ to a class C_k for some $1 \leq p \leq K$.
- (v) Compute the accuracy of the model \mathcal{M} on \mathbb{D}_{TS} .

For each dataset ID we repeat steps (*i*)-(*v*) ten times, each time randomly partitioning the dataset into subsets ID_{TR} and ID_{TS} . After ten experiments for each dataset are completed, the overall accuracy is obtained as the average of accuracies of the ten experiments.

4.2 Experimental Results

In order to test our proposed multi-class LAD methodology we conduct experiments on five multi-class datasets from UCI Machine Learning Repository ¹. Table 1 summarizes the characteristics of these datasets. For each dataset the average accuracy of ten experiments as well as the overall completion time are included in Table 2. The average sensitivities per class for each dataset are shown in Tables 3 and 4.

5 Conclusions

In this paper we have proposed a multi-class LAD classification algorithm. Our discussion started reviewing various efforts done in order to extend LAD classification that was originally conceived only for a two-class dataset. Rather than using the traditional enumerative approach, we have adopted the vision of Ryoo and Jang (2009) by using an MILP approach to generate LAD patterns. These researchers proposed an algorithm that works properly with

Dataset	C1	C2	C3	C4	C5	C6
Iris	100%	91%	91%			
Synthetic control	93%	89%	86%	88%	98%	88%
Glass ID	84%	83%	61%	56%	65%	86%
Wine	96%	85%	95%			

 Table 3: Average sensitivity

CNAE-9	C1	C2	C3	C4	C5
	87%	85%	77%	67%	97%
CNAE-9	C6	C7	C8	C9	
	70%	89%	91%	60%	

Table 4: Average sensitivity - CNAE-9

two-class datasets. We have extended their work to be used for the classification of datasets with K classes. We have also added parallel programming to speed up the computations. Our experiments on a collection of benchmark multiclass datasets show that the proposed multi-class LAD algorithm produces highly accurate classification models. Our multi-class methodology integrates principles from integer programming and computer related advancements to efficiently generate LAD patterns. It is a very promising option to solve multi-class classification problems.

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